

**N-Channel Enhancement Mode Power MOSFET**

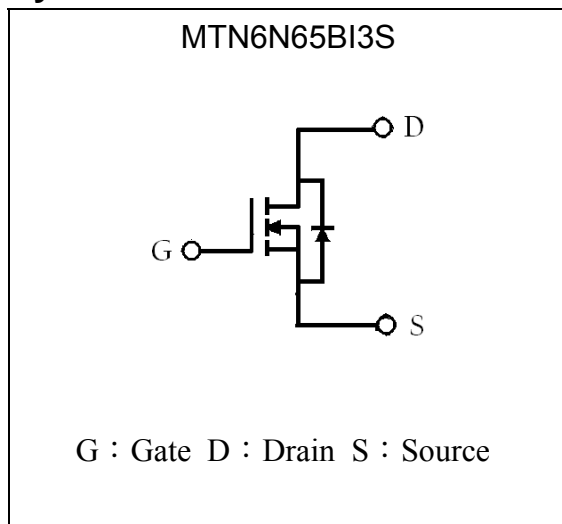
# MTN6N65BI3S

<b>BV<sub>DSS</sub></b>	<b>650V</b>
<b>I<sub>D</sub>@V<sub>GS</sub>=10V, T<sub>C</sub>=25°C</b>	<b>6A</b>
<b>R<sub>DS(ON)</sub>@V<sub>GS</sub>=10V, I<sub>D</sub>=3A</b>	<b>1.2Ω (typ)</b>

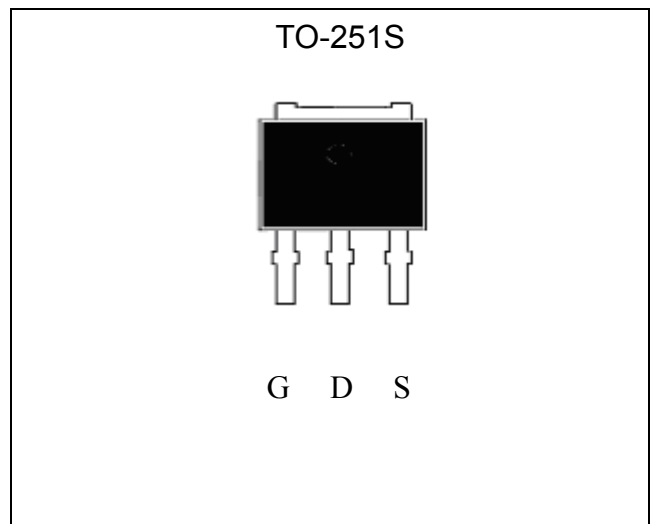
**Features**

- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- RoHS compliant package

**Symbol**

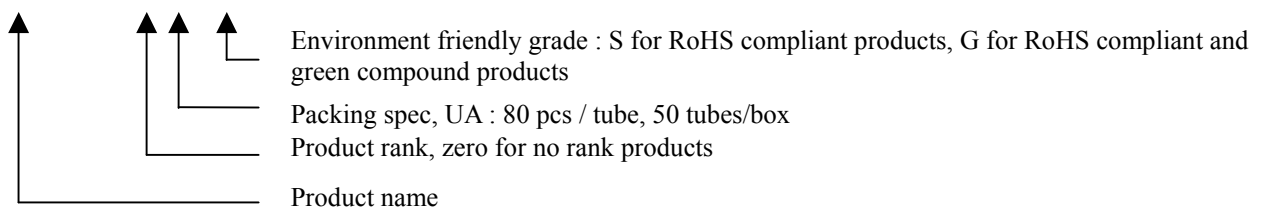


**Outline**



**Ordering Information**

Device	Package	Shipping
MTN6N65BI3S-0-UA-G	TO-251S (RoHS compliant and halogen-free package)	80 pcs/tube, 50 tubes/box





**Absolute Maximum Ratings** (T<sub>C</sub>=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V <sub>DS</sub>	650	V
Gate-Source Voltage	V <sub>GS</sub>	±30	
Continuous Drain Current @T <sub>C</sub> =25°C, V <sub>GS</sub> =10V	I <sub>D</sub>	6	A
Continuous Drain Current @T <sub>C</sub> =100°C, V <sub>GS</sub> =10V		3.8	
Pulsed Drain Current (Note 1)	I <sub>DM</sub>	24	
Single Pulse Avalanche Energy (Note 2)	E <sub>AS</sub>	106	mJ
Avalanche Current (Note 1)	I <sub>AS</sub>	5.5	A
Repetitive Avalanche Energy (Note 1)	E <sub>AR</sub>	9	mJ
Maximum Temperature for Soldering @ Lead at 0.125 in(0.318mm) from case for 10 seconds	T <sub>L</sub>	300	°C
Total Power Dissipation (T <sub>A</sub> =25°C)	P <sub>D</sub>	1.25	W
Total Power Dissipation (T <sub>C</sub> =25°C)		89	W
Linear Derating Factor		0.71	W/°C
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

Note : 1.Repetitive rating; pulse width limited by maximum junction temperature.

2. I<sub>AS</sub>=5.5A, V<sub>DD</sub>=50V, L=7mH, V<sub>GS</sub>=10V, starting T<sub>J</sub>=+25°C. 100% tested by conditions of L=7mH, I<sub>AS</sub>=3A, V<sub>GS</sub>=10V, V<sub>DD</sub>=50V.

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R <sub>th,j-c</sub>	1.4	°C/W
Thermal Resistance, Junction-to-ambient, max	R <sub>th,j-a</sub>	100	

**Characteristics (T<sub>C</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	650	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA, T <sub>J</sub> =25°C
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	-	0.6	-	V/°C	Reference to 25°C, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	2	-	4	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
*G <sub>FS</sub>	-	8.2	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =3A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±30V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V
	-	-	10		V <sub>DS</sub> =520V, V <sub>GS</sub> =0V, T <sub>C</sub> =125°C
*R <sub>DS(ON)</sub>	-	1.2	1.5	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =3A
<b>Dynamic</b>					
*Q <sub>g</sub>	-	28.6	-	nC	I <sub>D</sub> =6A, V <sub>DD</sub> =520V, V <sub>GS</sub> =10V
*Q <sub>GS</sub>	-	5.4	-		
*Q <sub>GD</sub>	-	12.2	-		
*t <sub>d(ON)</sub>	-	21.6	-	ns	V <sub>DS</sub> =325V, I <sub>D</sub> =6A, V <sub>GS</sub> =10V, R <sub>G</sub> =25Ω
*t <sub>r</sub>	-	63.6	-		
*t <sub>d(OFF)</sub>	-	54	-		
*t <sub>f</sub>	-	27.6	-		

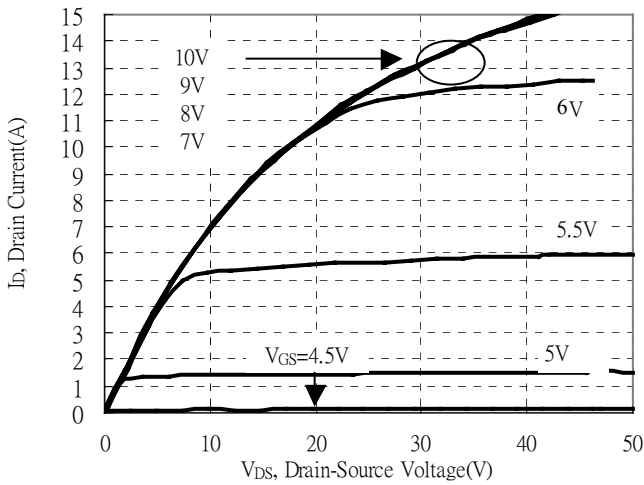


Ciss	-	891	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz
Coss	-	80	-		
Crss	-	9	-		
Rg	-	3	-	Ω	f=1MHz
<b>Source-Drain Diode</b>					
*I <sub>S</sub>	-	-	6	A	
*I <sub>SM</sub>	-	-	24		
*V <sub>SD</sub>	-	0.82	1.5	V	I <sub>S</sub> =6A, V <sub>GS</sub> =0V
*trr	-	370	-	ns	V <sub>GS</sub> =0V, I <sub>F</sub> =6A, dI <sub>F</sub> /dt=100A/μs
*Qrr	-	2.15	-	μC	

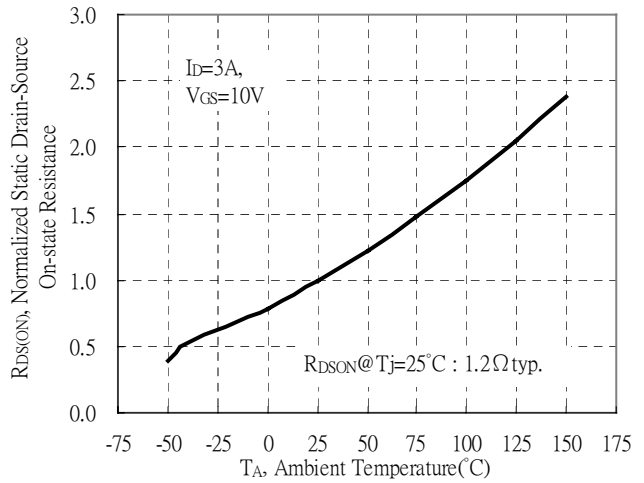
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

**Typical Characteristics**

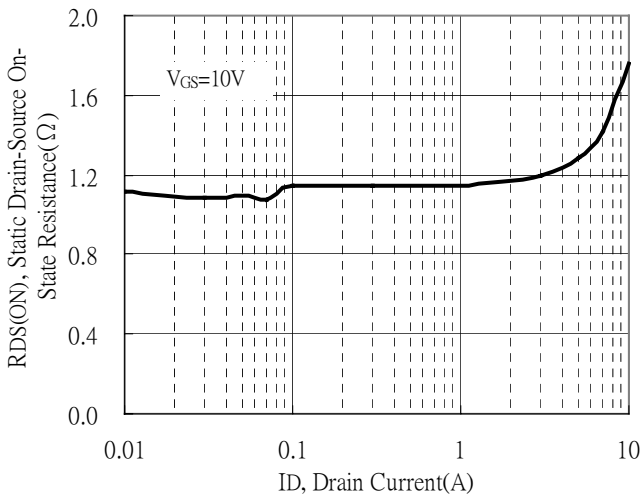
Typical Output Characteristics



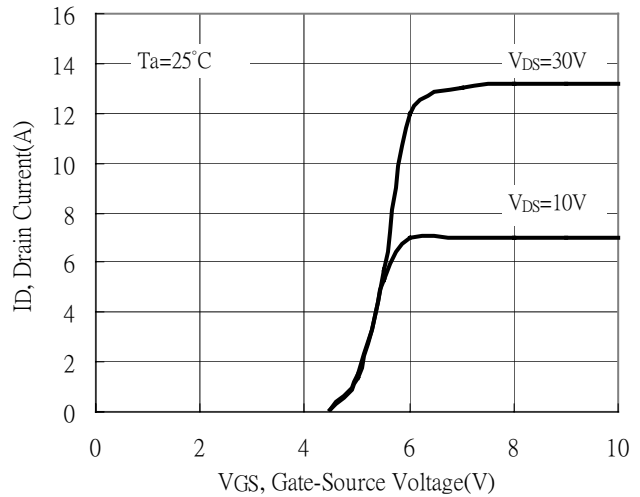
Static Drain-Source On-resistance vs Ambient Temperature



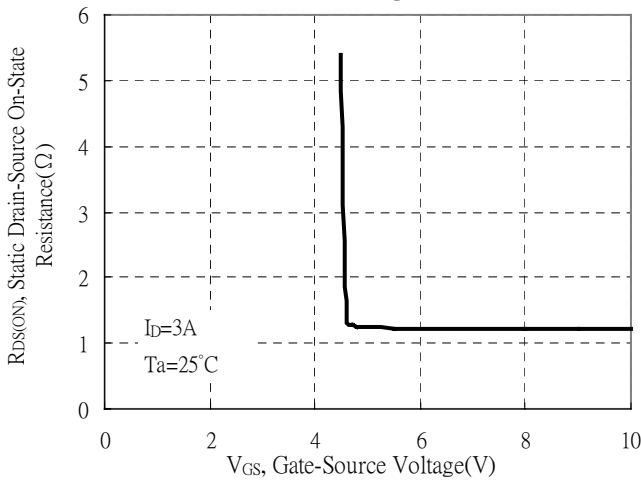
Static Drain-Source On-State resistance vs Drain Current



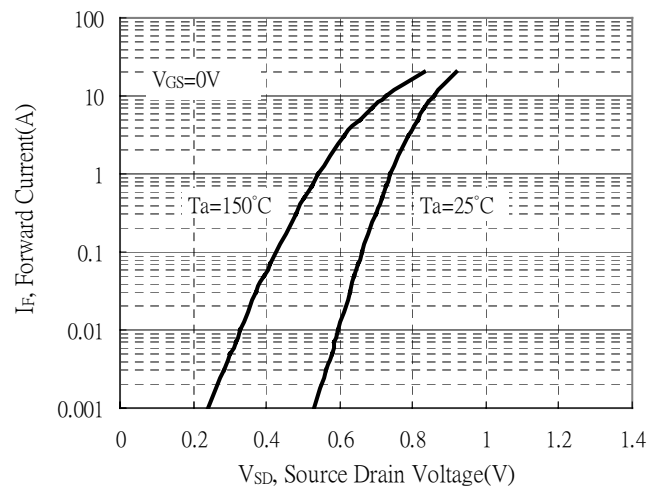
Drain Current vs Gate-Source Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

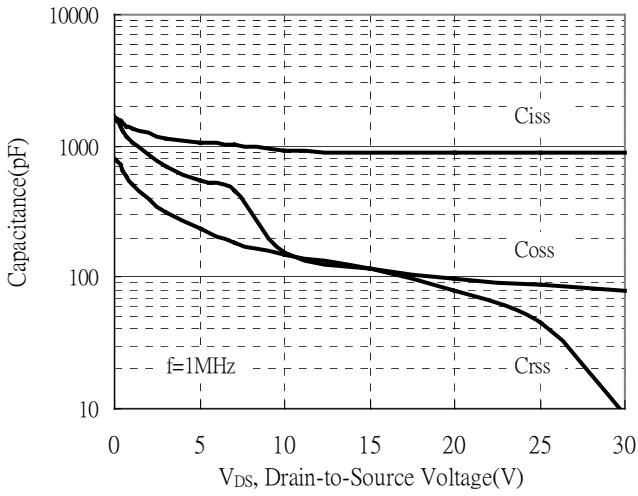


Forward Drain Current vs Source-Drain Voltage

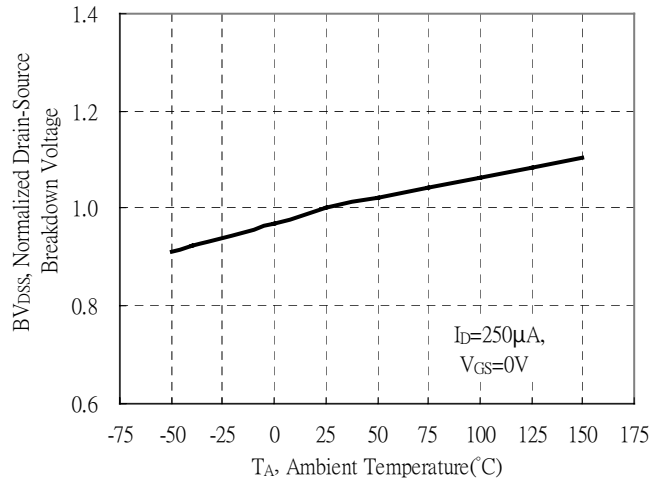


## Typical Characteristics(Cont.)

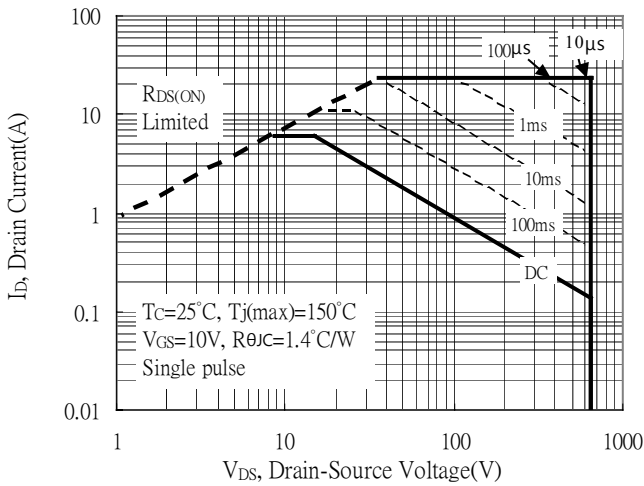
Capacitance vs Reverse Voltage



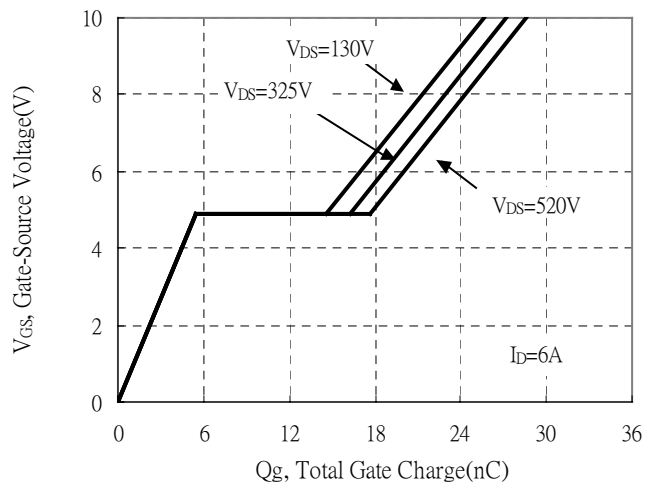
Brekdown Voltage vs Ambient Temperature



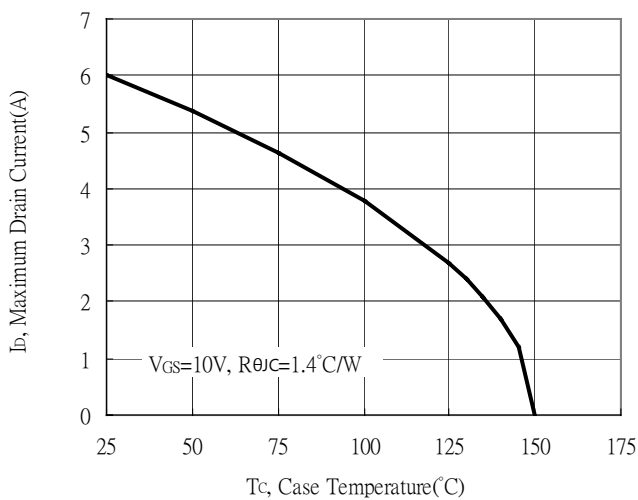
Maximum Safe Operating Area



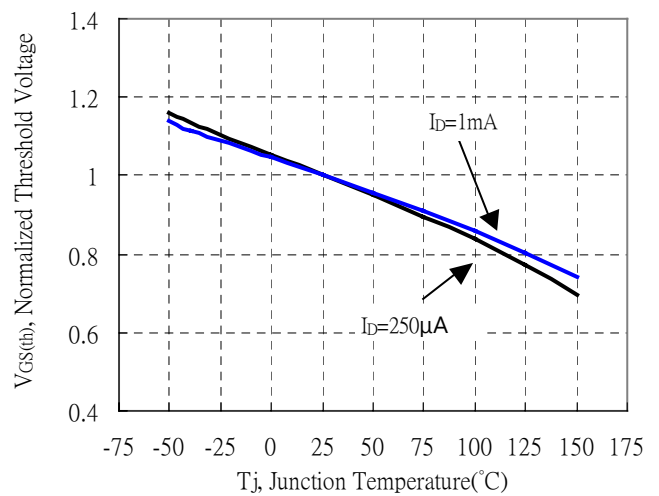
Gate Charge Characteristics



Maximum Drain Current vs Case Temperature



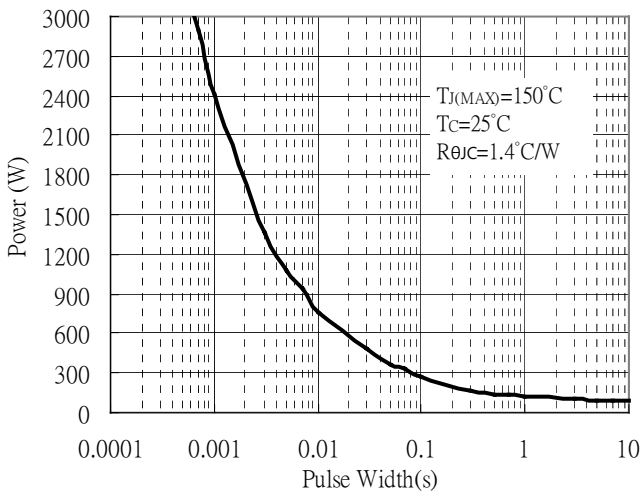
Threshold Voltage vs Junction Temperature



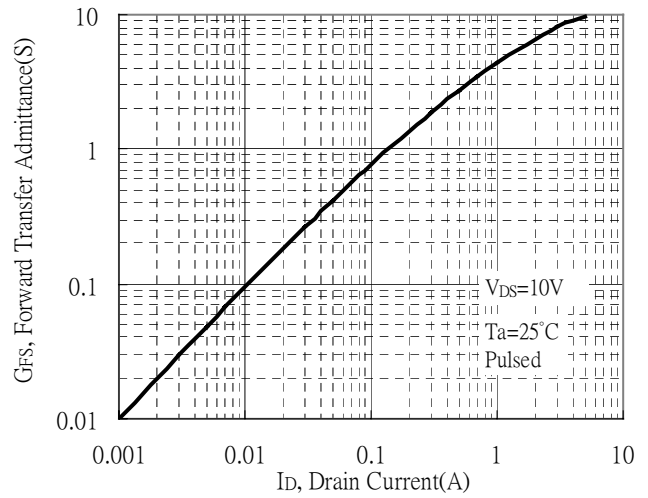


**Typical Characteristics(Cont.)**

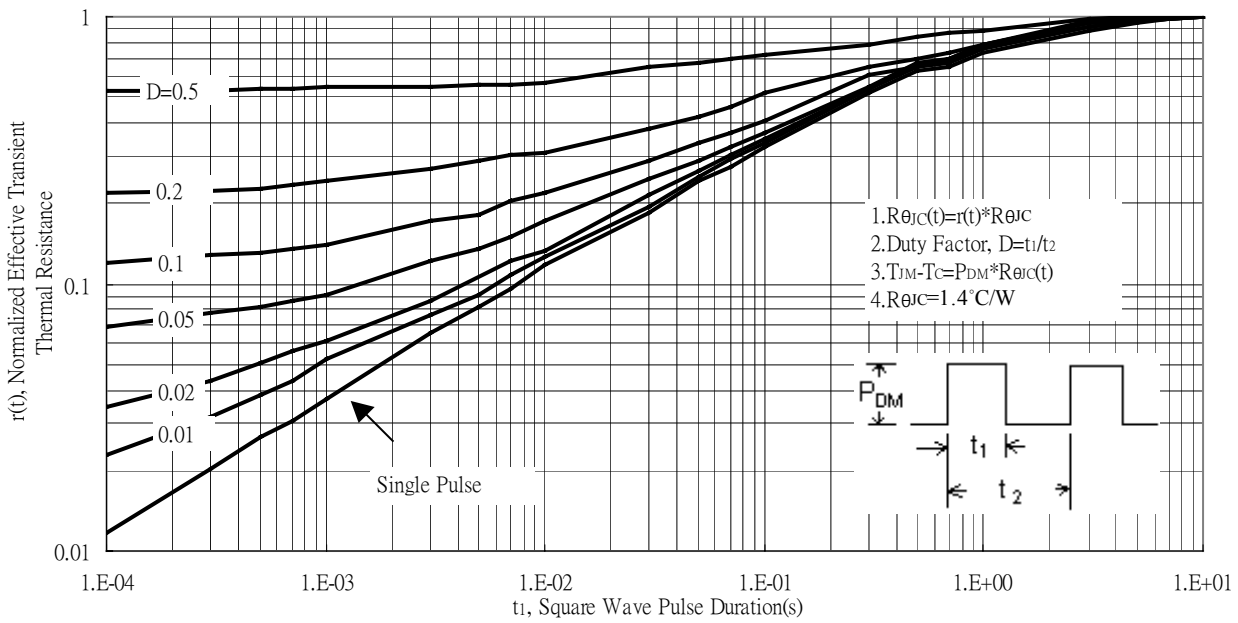
Single Pulse Power Rating, Junction to Case



Forward Transfer Admittance vs Drain Current



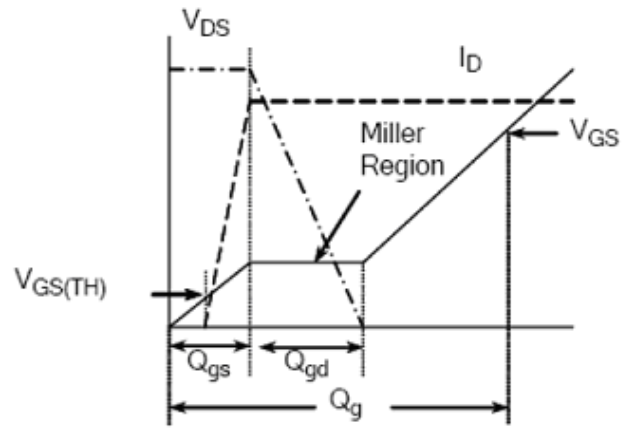
Transient Thermal Response Curves



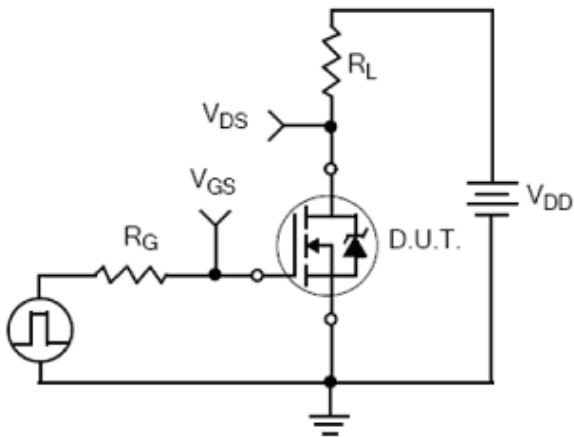
**Test Circuit and Waveforms**



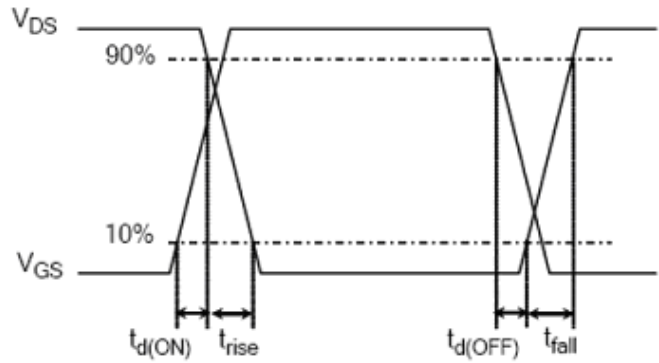
**Gate Charge Test Circuit**



**Gate Charge Waveform**



**Resistive Switching Test Circuit**

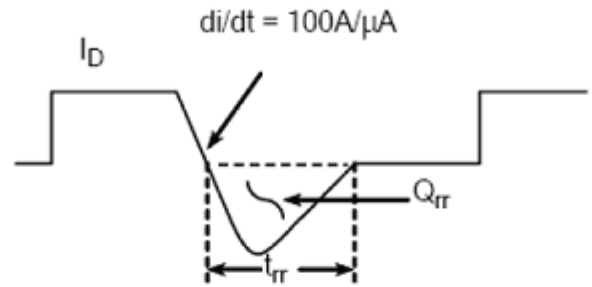


**Resistive Switching Waveforms**

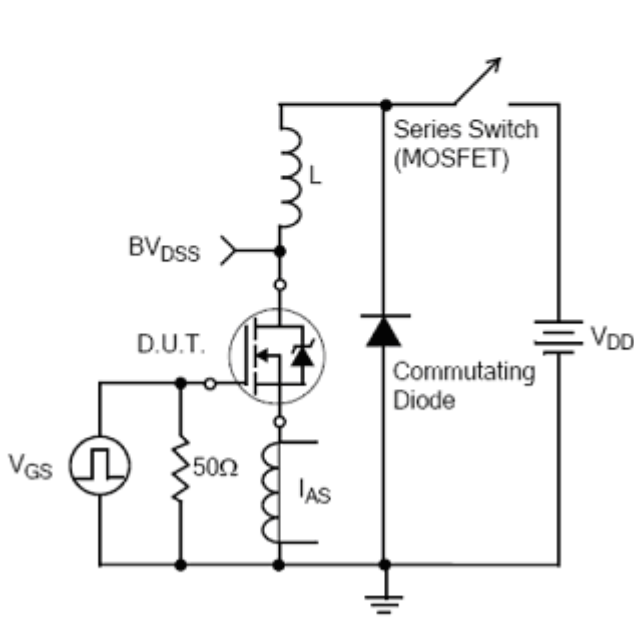
**Test Circuit and Waveforms(Cont.)**



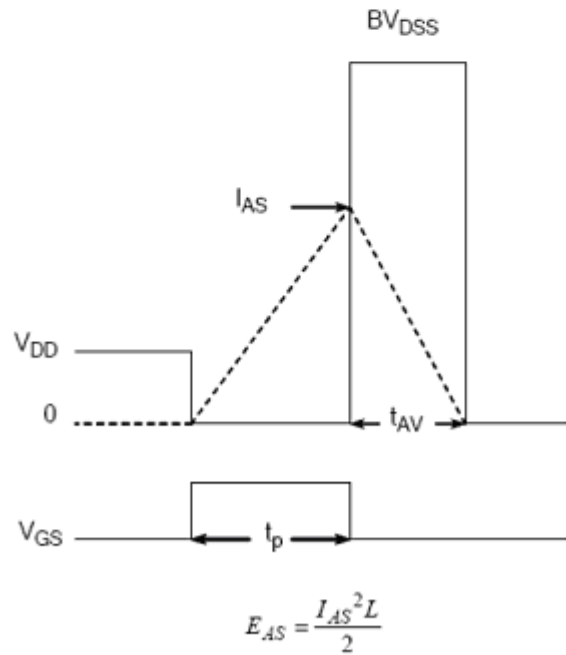
**Diode Reverse Recovery Test Circuit**



**Diode Reverse Recovery Waveform**



**Unclamped Inductive Switching Test Circuit**

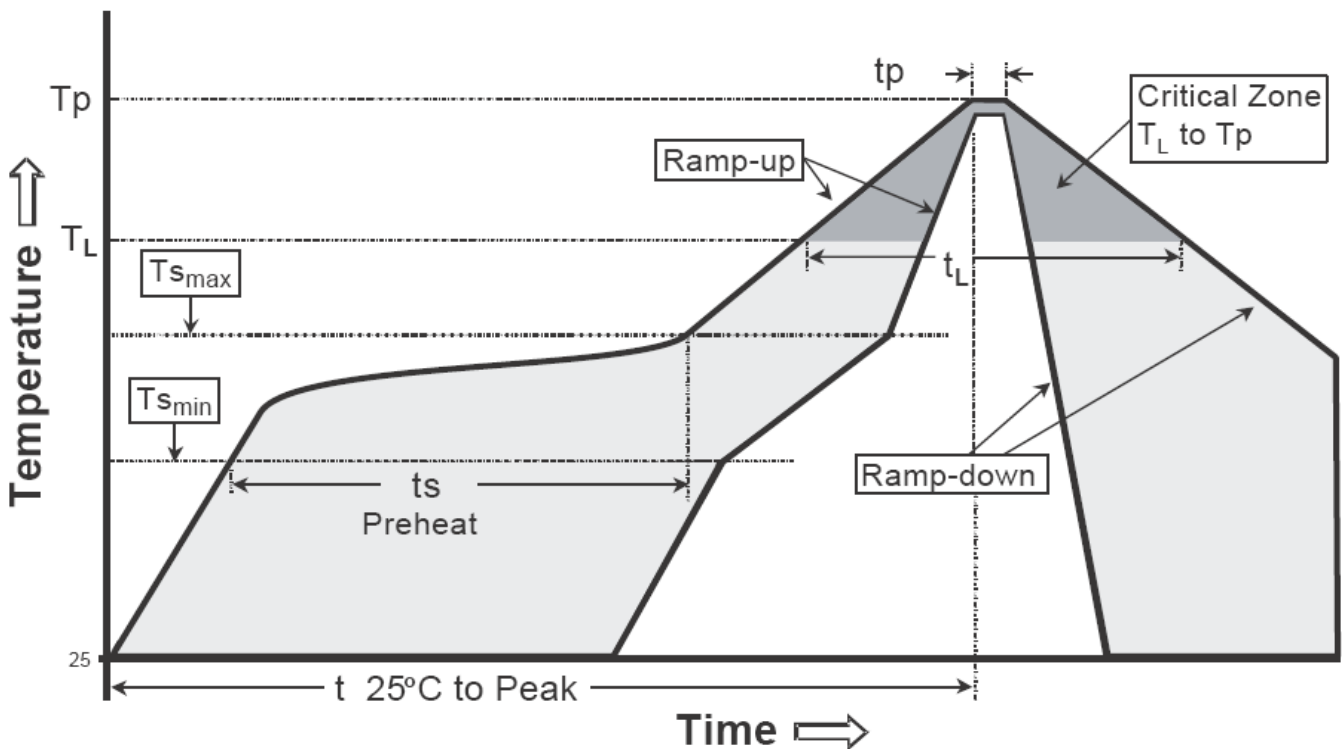


**Unclamped Inductive Switching Waveforms**



**Recommended wave soldering condition**

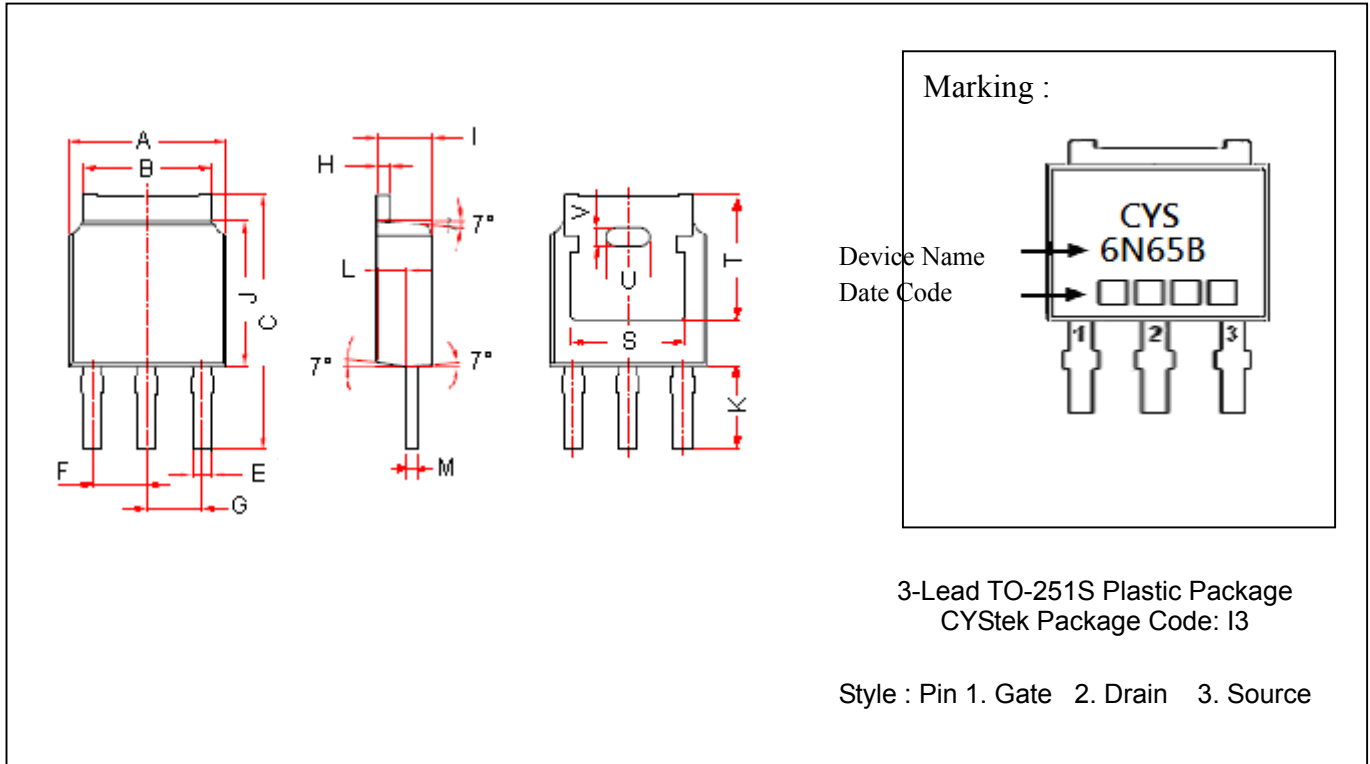
Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended temperature profile for IR reflow**


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (Tl)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**TO-251S Dimension**



Marking :

Device Name → **CYS 6N65B**  
 Date Code → □□□□

3-Lead TO-251S Plastic Package  
 CYStek Package Code: I3

Style : Pin 1. Gate 2. Drain 3. Source

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.2559	0.2638	6.50	6.70	J	0.2362	0.2441	6.00	6.20
B	0.2020	0.2126	5.13	5.46	K	0.1299	0.1457	3.30	3.70
C	0.4094	0.4331	10.40	11.00	L	0.0358	0.0437	0.91	1.11
E	0.0280	0.0319	0.71	0.81	M	0.0181	0.0220	0.46	0.56
F	0.0858	0.0941	2.18	2.39	S	0.1902	REF	4.83	REF
G	0.0858	0.0941	2.18	2.39	T	0.2106	REF	5.35	REF
H	0.0181	0.0220	0.46	0.56	U	0.0701	REF	1.78	REF
I	0.0902	0.0937	2.29	2.38	V	0.0299	REF	0.76	REF

Notes: 1.Controlling dimension: inch.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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